

Search Notes

Application/Control No.

10/784,705

Examiner

Son T. Dinh

Applicant(s)/Patent under
Reexamination

CHEN ET AL.

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	148	6/11/2005	SD
365	189.11	6/11/2005	SD
365	100	6/11/2005	SD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/11/2005	SD